


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/026,802	OHTANI ET AL.	
	Examiner	Art Unit	
	Junghwa M. Im	2811	

ISSUE CLASSIFICATION											
ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
257		59		257	59	57	347	49	50	64	627
INTERNATIONAL CLASSIFICATION				257	255	628	65	67	72	66	52
H	0	1	L	29/04	438	40	187	198	150		
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Junghwa Im 02-18-2005 (Assistant Examiner) (Date)				EDDIE LEE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) 2/12/05				Total Claims Allowed: 20			
Yolanda Robinson 2/22/05 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 16	O.G. Print Fig. 2B, 6E		

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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